IMAGING SYSTEM USING MULTI-MODE LASER ILLUMINATION ENHANCE IMAGE QUALITY

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This application is related to my US Patent Application, Serial No. 08/966,046, filed November 7, 1997 and provisional application Serial No. 60/072,334, filed January 23, 1998.

Description

The present invention related to imaging system which enhance image quality be reducing noise which reduces contrast in images, especially images obtained from turbid media, such as encountered in biological specimens, and especially dermatological tissue wherein keratin is present. Media, which are turbid, may be characterized by having a high RMS refractive index variation and high scattering cross sections.

The invention is especially suitable for use in confocal microscopy and especially in raster scanning confocal microscopes such as the Vivascope confocal scanning raster microscope sold by Lucid Technologies, Inc. of Henrietta, New York, U.S.A and described in an article by M. Rajadhyaksha, et al. entitled "*In Vivo Confocal Scanning Laser Microscopy of Human Skin, Melanin Provides Strong Contrast*" that appeared in the Journal of Investigative Dermatology, Volume 104, No. 6, pg. 1 (June 1995) and also the subject matter of an article by M. Rajadhyaksha and James M. Zavislan which appeared on Laser Focus World, pg. 119 (February, 1996) and in the hand-held scanning laser microscope which is the subject matter of US Patent Application Serial No. 08/650,684 filed May 20, 1996 in the name of James M. Zavislan, et al. The invention is also useful in optical coherence tomography or interference microscopy.

It has been discovered in accordance with the invention, that by illuminating a medium with low spatial coherence laser radiation, especially transverse multi-mode radiation and which propagates and in the TEM_{01} or higher modes, images obtained from return light from an image plane or section within a specimen, by responding to the intensity of the return light, have reduce image distortion. Distortion produced by scattering sites adjacent to the image plane or section tends to be minimized or at least reduced to a constant value, while optical signals due to index variations and other optical activity within the image plane

or section (region of interest) are actually detected. Thus, correlated noise from scatterers, which produces optical distortion and especially speckle effects in the image, is reduced, thereby enhancing the quality of the image. The focal region (image plane or section) may be at the surface of the specimen or embedded in the specimen and the incident light is focused at a laser beam waist into components of opposite phases. Outside the focal plane (in the section) the components overlap and destructively interfere before detection. Noise due to scattering sites away from the focal region may occur, whether the region is at the surface or embedded in the specimen. The section being imaged, especially in imaging of biological tissue, can be of the thickness of a cell, for example, about five microns.

Regions adjacent to the section of interest may have an abundance of scatterers, both behind and ahead of the section in the direction of propagation of the illuminating beam, which is incident on the section. These potential scattering sources are illuminated by the same optical field that illuminate the region of interest. There is a finite probability that return light from these scatterers will pass through a confocal aperture and reach the detector as optical signals from which the image of the section of interest is constructed. The spurious return light may manifest itself as speckle in the image. The use of multi-mode laser illumination, in accordance with the invention, has been found to reduce such distortion, and especially speckle distortion, thereby providing additional contrast and enhancing the image quality.

Confocal microscopes have heretofore used single mode lasers which propagate usually in the TEM_{00} mode, in order to obtain a single component spot or dot in the focal plane. As described in RE 34, 214 issued April 6, 1993 to Carlsson, the laser beam is focused at a single spot in the focal plane which is conjugate optically to the confocal aperture. The present invention uses a plurality of spots due to lobes (components) of multi-mode, preferably TEM_{01} or higher modes, which lobes are in out of phase amplitude relationship where such modes are focussed (at the laser beam waist-which lies in the focal plane). The lobes overlap outside the focal plane, thus reducing the spurious, undesirable returns from scattering sites outside of the focal plane, which defines the section of the specimen of interest. The above referenced applications use polarization techniques to shear the beams which, like the multi-mode illumination, produces spots which are spaced apart in

the focal plane and overlap and cancel spurious reflections (as from scatters) outside the focal plane, but required polarization prisms and lenses. More specifically my prior applications, Serial Nos. 08-966046 and 60/072,334, referenced above, further enhance image quality in imaging systems by utilizing circularly polarized beams focused on the image plane thereby obtaining noise reduction in the image, especially speckle noise which may be attributable to scatterers adjacent to the image plane. The spots may be laterally offset or vertically offset and provide different modalities for imaging.

The noise reduction system described herein also has application to optical coherence imaging often referred to as optical coherence-domain reflectivity, optical coherence tomograph or optical coherence microscopy. (See Schmitt, et al, *Optical characterization of dense tissues using low-coherence interferometry*, SPIE, Vol. 1889, pps. 197-211, July, 1992). In this imaging modality, a low temporal coherence source is used to illuminate an interferometer with a phase-modulated reference arm and a sample arm. In the sample arm, a focussing objective directs light into a sample, often a turbid biological specimen. Only light which is scattered from a depth in the tissue that has equal optical path as the optical path of the reference arm constructively interferes at the detector to provide an electronic signal that represents the optical signal from the sample. This coherence requirement eliminates the need for a confocal pinhole to select the image plan inside the tissue. Optical coherence imaging however, suffers from the same deleterious effect of adjacent scatters as does confocal imaging. This effect is reduced, however, by the multi-mode laser illumination and detection system previously described.

Accordingly, it is the principal object of the present invention to provide improved imaging systems, and especially imaging systems using confocal microscopy, and more especially improved laser scanning confocal microscopes.

It is a further object of the present invention to provide improved confocal microscopes and especially improved laser scanning confocal microscopes.

It is a still further object of the invention to provide improved confocal laser scanning microscopes which provide images of biological tissue, and especially dermatological tissue.

It is a still further object of the inventor to provide improved instruments using optical coherence interferometry.

Briefly described, a system embodying the invention enables viewing a section of a medium. Light is received by and returned from the section and from sites adjacent to the section. The system utilizes transverse multi-mode laser illumination to provide light which is incident on the medium. This incident illumination is focused in the section being imaged to provide spots which are spaced from each other in the plane of the section of interest. The spots are due to the lobes or components of the incident multi-mode laser light which are in opposing (180°) phase amplitude relationship. The lobes overlap outside of the focal plane, thereby providing inference of light returned from the sites (scatterers) adjacent to the section being imaged. The image may be constructed in response to the intensity of the return light.

The foregoing and other objects, features and advantages of the invention, as well as presently preferred embodiments thereof, will become more apparent from reading of the following discussion in connection with the accompanying drawings in which:

FIG. 1 is a schematic diagram of a laser scanning confocal microscope which embodies the invention;

FIGS. 1A & B are schematic diagrams of optical arrangements for synthesizing multi-mode beams for confocal or optical coherence imaging

FIG. 2 is a schematic diagram illustrating the processing, in the microscope of FIG. 1, of the incident multi-mode light and the collection of the return light from an image section which is shown as a focal plan;

FIGS. 2A, B and C are plots of the amplitude of the multi-mode laser beam at the beam waist in the focal plan shown in FIG. 2, for TEM_{011} TEM_{02} TEM_{03} illumination respectively.

FIG. 3 is a schematic diagram showing the collection optics in the return arm of a confocal microscope system of the type illustrated in FIG. 1 which detects intensity of the return light and enables the construction of the image in response thereto; and

FIG. 4 is a schematic diagram of an optical coherence imaging system embodying the invention.

Referring to FIG. 1, there is shown a confocal laser scanning microscope wherein the beam, which is made incident on and illuminates a turbid sample 12, is obtained from multi-

mode laser 14, and which in the case where the microscope is used to image a section of dermatological tissue (forming a turbid sample 12), is preferable in the infra-red range. The incident beam from the laser may be linearly polarized as indicated by the arrow 16. Then, polarizing beam splitter 18 passes the incident beam to scanning optics 20. However, the polarization of the incident beam is not restrictive and any polarization, even circular, may be used.

The scanning optics provide scanning in an X,Y direction, where X and Y are coordinates orthogonal to each other in the image plane. The scanning optics may be an undulating or pivoting mirror and a rotating polygon mirror as in the Vivascope laser scanning confocal microscope referenced above. Orthogonal mirrors may provide the scanning optics, as in the confocal scanning microscope described in the above-referenced publications. The scanning optics is controlled by a computer controller 22 which also collects image data from a photo detector 24 and constructs the image either on a display, printer or a recorder 26.

The incident and return beams are deflected by a mirror 28 through quarter wave plate toward the sample 12 and pass through an objective lens system 30 to the focal or image plane in the sample 12.

The return light from the image plane is again deflected by the scanning optics 20 and deflected by the beam splitter 18 through detector optics (a condenser lens system) 34 to the detector. The detector optics focuses the light at the center of a confocal aperture 36. In order to select the image plan, the objective 30 together with any processing optics 32 (which may be an assembly) is movable under control of the computer control 22 in the Z direction which is a direction perpendicular to the X and Y direction as shown at 40. So far described, except for the processing elements, the confocal laser scanning microscope 10 is similar to that described in the referenced article and patent application.

The multi-mode laser 14 may produce multi-mode TEM_{01} or higher (e.g., TEM_{02} or TEM_{03}) modes of propagation by design of its cavity. The laser may be a laser diode pumped YAG laser which generates light at about 1.06 micron wavelength, but instead of as a diffraction limited single-lobed beam, produces a multi-lobed beam. The mirrors at the ends the cavity or one of them may be cocked away from the confocal axis to enhance the

TEM_{01} mode. Alternatively, a split thin film ($\lambda/2$) retarder can be used to generate the TEM_{01} mode or TEM_{02} mode outside of the cavity as shown in FIGS. 1A & FIG. 1B. Reference may be had to the following for more information or to the design of a suitable multi-mode laser: O. Svelto, Principles of Lasers, 3RD Edition, Plenum Press, NY & London, 1989 see, especially, pps. 137-206.

Referring to FIG. 2, the TEM_{01} mode effectively provides two beam components A and B. The beam components A and B are focused as spots C and D, respectively in the focal or image plan 58. It will be appreciated that these spots are scanned in X, Y and Z over the image plan in order to provide optical signals from which the image can be constructed, after detection by the detector 24, in the computer 22.

The components are two lobes of TEM_{01} focused mode. The components are 180° out of phase They form an optical beam with two laterally offset illumination zones which have substantially overlap of the two beams in regions away from the beam waist. Thus, scatterers outside of focus will create a scattered light field with two electric field modes that are out of phase. These two electric fields will cancel as the collected scattered light is imaged to the confocal aperture 36 which is conjugate to the illuminating beam waist. As shown in FIGS. 2B and C, higher modes may be used. In the TEM_{02} mode are in spaced pairs of about equal and opposite amplitude.

The light is returned and collected by the objective 30 and combined. The intensity of light returned from the spots C and D depends upon the optical reflectance averaged across the spots C and D. The intensity is the sum of the squares of the intensity of the light returned from each spot C and D. Accordingly, the amount of light from the image plane which is focused by the condenser 34 and passes through the confocal aperture as the optical signal which is detected by the detector 24, depends upon the effect of the material specimen in the focal plane.

Referring to FIG. 3, collection optics of the invention is illustrated. There, a polarizing or leaky beam splitter 60 passes the laser light beam to the scanning optics. The intensity of the light from the scatterers outside of the focal plane in the sum of the intensity of each TEM_{01} component. The return beam is then focused by detector optics 34 at the confocal aperture 36 and then detected by the photo detector 24. Since the TEM_{01}

components overlap, they interfere and cancel in the combined beam passing through the confocal aperture 36.

FIG. 4 shows an optical coherence imaging system with improved imaging. A low temporal coherence optical source 230 provides transverse multi-mode illumination. The laser 14 or the techniques of FIGS. 1A and 1B may be used, but a super luminescent diode or femtosecond laser is suitable. The light therefrom is collimated by lens 235. A linear polarizer 265 polarizes the incident light. The polarization state is oriented to be in the plane of FIG. 4. The light then passes into beam splitter 240 which is nominally 50%-50% non-polarizing beam splitter. A portion of the light is directed to a reference mirror 250. Reference mirror 250 is actuated by transducer 255, which may be a piezo-electric actuator. This actuation modulates the phase of the reference arm light.

Light scattered from the two spots inside or on the object is collected by lens 210 and angularly combined in the objective 210 and directed towards the beam splitter 240. A portion of the reference and sample light is directed to a photodetector and signal conditioning circuit 245 which may be a silicon photodiode and amplifier. The portion of the light from both arms incident on the detector that is both parallel and coherent will interfere in a detection arm terminated at the detector 245 and produce a phase modulated electric signal which varies synchronously with the reference mirror position. The amplitude of the modulated signal is proportional to the reflectance of the subject at the point inside the object that has equal optical path as the reference arm to within the coherence length of the source.

As with the confocal system described previously, there are signal contributions from scatterers above and below the surface which equal path as the reference arm. These scatters will produce speckle noise that interferes with the fidelity of the signal. The scatterers which are outside the surface of equal optical path will be illuminated by the overlapping lobes or components. The light from these scatters will be substantially destructively interfering at the detector because the two components have 180° phase difference and illuminate each of the scatterers similarly.

Controller 260 controls the scan position of the objective lens 210 through actuator 225. Controller 260 also controls the position of actuator 255 which controls the position of

the reference mirror 250. The controller collects the signal and decodes it with the position information of the actuators and drives a display or recorder 270.

From the foregoing description, it should be apparent that there has been provided an improved imaging system, and especially an imaging system which is especially adapted for providing improved confocal microscopes and especially laser scanning confocal microscopes and which is also applicable for optical coherence tomograph or microscopy. Variations and modifications in the herein described system, within the scope of the invention, will undoubtedly suggest themselves to those skilled in the art. Accordingly, the foregoing description should be taken as illustrated and not in a limiting sense.